#### HAMAMATSU



# InAsSb photodiode

P11120-901

# Infrared detector in the 5 µm spectral band, with high sensitivity and high reliability

The P11120-901 is an infrared detector that provides high sensitivity in the 5  $\mu$ m spectral band due to our unique crystal growth technology. The InAsSb photodiode used in the detector has a planar structure that ensures high-speed response and high reliability. Typical applications include gas analysis such as CO<sub>2</sub>, SO<sub>x</sub>, CO and NO<sub>x</sub>. HAMAMATSU also manufactures detector elements with peak sensitivity at longer wavelengths by changing the composition ratio of As and Sb.

#### Features

- High speed response
- High sensitivity
- High reliability

#### Applications

- Gas analysis
- Thermometers (radiometers)
- Thermal imaging
- Remote sensing
- **→** FTIR
- Spectrophotometry

#### Specifications

Parameter	Specification	Unit
Window material	Si with AR coated	-
Package	Metal dewar	-
Cooling	Liquid nitrogen	-
Active area	φ1.0	mm

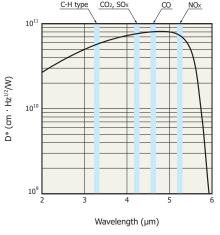
#### **⇒** Absolute maximum ratings

Parameter	Symbol	Value	Unit
Reverse voltage	VR	0.1	V
Operating temperature	Topr	-40 to +60	°C
Strage temperature	Tstg	-55 to +60	°C

#### **Electrical and optical characteristics**

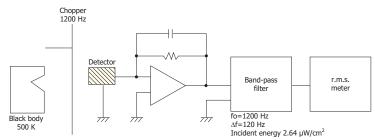
Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Peak sensitivity wavelength	λр		4.6	4.8	5.2	μm
Cut-off wavelength	λς		5.6	5.8	-	μm
Photo sensitivity	S		0.7	0.8	-	A/W
Shunt resistance	Rsh		7 × 10 <sup>4</sup>	1 × 10 <sup>5</sup>	-	Ω
Detectivity	D*	(λp, 1200, 1)	$6.0 \times 10^{10}$	$8.5 \times 10^{10}$	-	cm·Hz <sup>1/2</sup> /W
Noise equivalent power	NEP	λ=λρ	-	1.1 × 10 <sup>-12</sup>	$1.5 \times 10^{-12}$	W/Hz <sup>1/2</sup>
Rise time	tr		-	200	300	ns

## **Spectral response**



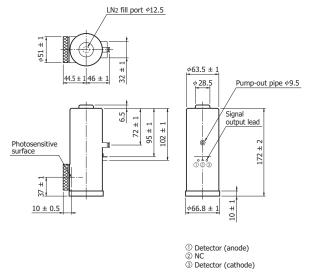
#### KIRDB0430EA

## **►** Measurement circuit example



KIRDC0004EA

#### Dimensional outline (unit: mm)



KIRDA0190EC

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# **HAMAMATSU**

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